

<b>Notice of References Cited</b>	Application/Control No. 10/530,965	Applicant(s)/Patent Under Reexamination KITAMURA ET AL.	
	Examiner MICHAEL M. BERNSHTEYN	Art Unit 1796	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0076594	06-2002	Fukuda et al.	429/30
*	C	US-2002/0091225	07-2002	McGrath et al.	528/170
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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